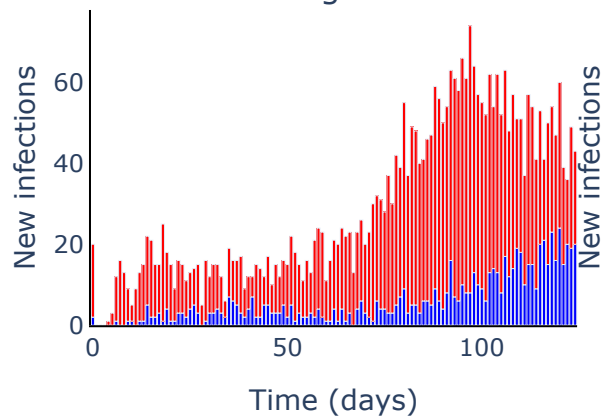


Different generation time intervals, correct generation time

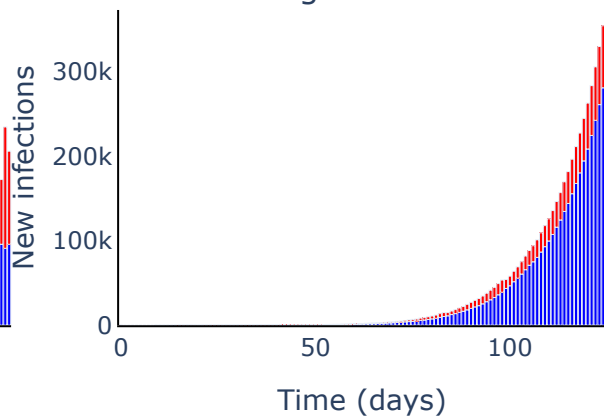
changing conditions

■ Incidence group 1 ■ Incidence group 2

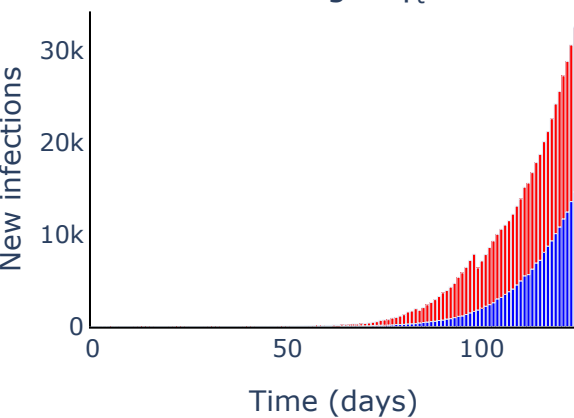
Original



Changed Contacts



Changed γ_t



Changed ICs

